

Maximum Ratings / Höchstzulässige Werte

Parameter	Condition	Symbol	Values	Unit
			max.	
Input Rectifier Bridge				
Gleichrichter				
Repetitive peak reverse voltage		V_{RRM}	1600	V
Periodische Rückw. Spitzenspersspannung				
Forward current per diode	DC current $T_n=80^\circ\text{C}$;	I_{FAV}	40 limited by power terminal	A
Dauergrenzstrom	$T_c=80^\circ\text{C}$		40 limited by power terminal	
Surge forward current	$t_p=10\text{ms}$ $T_j=25^\circ\text{C}$	I_{FSM}	370	A
Stoßstrom Grenzwert				
I^2t -value	$t_p=10\text{ms}$ $T_j=25^\circ\text{C}$	I^2t	680	A ² s
Grenzlastintegral				
Power dissipation per Diode	$T_j=150^\circ\text{C}$ $T_n=80^\circ\text{C}$	P_{tot}	50	W
Verlustleistung pro Diode	$T_c=80^\circ\text{C}$		76	
Transistor Inverter				
Transistor Wechselrichter				
Collector-emitter break down voltage		V_{CE}	1200	V
Kollektor-Emitter-Sperrspannung				
DC collector current	$T_j=150^\circ\text{C}$ $T_n=80^\circ\text{C}$,	I_C	27	A
Kollektor-Dauergleichstrom	$T_c=80^\circ\text{C}$		35	
Repetitive peak collector current	$t_p=1\text{ms}$ $T_n=80^\circ\text{C}$	I_{cpuls}	54	A
Periodischer Kollektorspitzenstrom				
Power dissipation per IGBT	$T_j=150^\circ\text{C}$ $T_n=80^\circ\text{C}$	P_{tot}	56	W
Verlustleistung pro IGBT	$T_c=80^\circ\text{C}$		85	
Gate-emitter peak voltage		V_{GE}	± 20	V
Gate-Emitter-Spitzenspannung				
SC withstand time	$T_j \leq 125^\circ\text{C}$ $V_{GE}=15\text{V}$	t_{SC}	10	us
Kurzschlußverhalten	$V_{CC}=900\text{V}$			
Diode Inverter				
Diode Wechselrichter				
DC forward current	$T_j=150^\circ\text{C}$ $T_n=80^\circ\text{C}$,	I_F	23	A
Dauergleichstrom	$T_c=80^\circ\text{C}$		31	
Repetitive peak forward current	$t_p=1\text{ms}$ $T_n=80^\circ\text{C}$	I_{FRM}	47	A
Periodischer Spitzenstrom				
Power dissipation per Diode	$T_j=150^\circ\text{C}$ $T_n=80^\circ\text{C}$	P_{tot}	41	W
Verlustleistung pro Diode	$T_c=80^\circ\text{C}$		62	
Transistor BRC				
Transistor BRC				
Collector-emitter break down voltage		V_{CE}	1200	V
Kollektor-Emitter-Sperrspannung				
DC collector current	$T_j=150^\circ\text{C}$ $T_n=80^\circ\text{C}$	I_C	32	A
Kollektor-Dauergleichstrom	$T_j=150^\circ\text{C}$ $T_c=80^\circ\text{C}$		36	
Repetitive peak collector current	$t_p=1\text{ms}$ $T_n=80^\circ\text{C}$	I_{cpuls}	64	A
Periodischer Kollektorspitzenstrom				
Power dissipation per IGBT	$T_j=150^\circ\text{C}$ $T_n=80^\circ\text{C}$	P_{tot}	69	W
Verlustleistung pro IGBT	$T_c=80^\circ\text{C}$		105	
Gate-emitter peak voltage		V_{GE}	± 20	V
Gate-Emitter-Spitzenspannung				
SC withstand time	$T_j \leq 125^\circ\text{C}$ $V_{GE}=15\text{V}$	t_{SC}	10	us
Kurzschlußverhalten	$V_{CE}=900\text{V}$			

Maximum Ratings / Höchstzulässige Werte

Parameter	Condition	Symbol	Values	Unit
			max.	
Diode BRC				
Diode BRC				
DC forward current Dauergleichstrom	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$ $T_j=150^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	I_F	25 31	A
Repetitive peak forward current Periodischer Spitzenstrom	$t_p=1\text{ms}$ $T_h=80^{\circ}\text{C}$	I_{FRM}	49	A
Power dissipation per Diode Verlustleistung pro Diode	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	P_{tot}	45 69	W
Thermal properties				
Thermische Eigenschaften				
max. Chip temperature max. Chiptemperatur		T_{jmax}	150	$^{\circ}\text{C}$
Storage temperature Lagertemperatur		T_{stg}	-40...+125	$^{\circ}\text{C}$
Operation temperature Betriebstemperatur		T_{op}	-40...+125	$^{\circ}\text{C}$
Insulation properties				
Modulisolation				
Insulation voltage Isolationsspannung	$t=1\text{min}$	V_{is}	4000	Vdc
Creepage distance Kriechstrecke			min 12,7	mm
Clearance Luftstrecke			min 12,7	mm

Characteristic values

Description	Symbol	Conditions					Values			Unit
		T(°C)	Other conditions (Rgon-Rgoff)	V _{GE} (V) V _{GS} (V)	V _R (V) V _{CE} (V) V _{DS} (V)	I _C (A) I _F (A) I _d (A)	Min	Typ	Max	
Input Rectifier Bridge										
Gleichrichter										
Forward voltage Durchlaßspannung	V _F	T _j =25°C T _j =125°C				25	0,8	1,08	1,35	V
Threshold voltage (for power loss calc. only) Schleusenspannung	V _{to}	T _j =25°C T _j =125°C				25		0,89	0,78	V
Slope resistance (for power loss calc. only) Ersatzwiderstand	r _t	T _j =25°C T _j =125°C						0,008	0,01	Ohm
Reverse current Sperstrom	I _r	T _j =25°C T _j =140±10°C			1500 1500		0		0,1 1,5	mA
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R _{thJH}		Thermal grease thickness≤50um					1,39		K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R _{thJC}		Wärmeleitpaste Dicke≤50um λ = 0,61 W/mK					0,92		K/W
Transistor Inverter										
Transistor Wechselrichter										
Gate emitter threshold voltage Gate-Schwellenspannung	V _{GE(th)}	T _j =25°C T _j =125°C	V _{CE} =V _{GE}			0,001	5	5,8	6,5	V
Collector-emitter saturation voltage Kollektor-Emitter Sättigungsspannung	V _{CE(sat)}	T _j =25°C T _j =125°C		15 15		25 25	1,35	1,71	2,15	V
Collector-emitter cut-off current incl. Diode Kollektor-Emitter Reststrom	I _{CEs}	T _j =25°C T _j =125°C		0	1224		0		0,05	mA
Gate-emitter leakage current Gate-Emitter Reststrom	I _{GES}	T _j =25°C T _j =125°C		±25	0		0		300	nA
Integrated Gate resistor Integriertes Gate Widerstand	R _{gint}							8		Ohm
Turn-on delay time Einschaltverzögerungszeit	t _{d(on)}	T _j =25°C T _j =125°C	R _{goff} = 36 Ohm R _{gon} = 36 Ohm	±15	600	25		76		ns
Rise time Anstiegszeit	t _r	T _j =25°C T _j =125°C	R _{goff} = 36 Ohm R _{gon} = 36 Ohm	±15	600	25		25		ns
Turn-off delay time Abschaltverzögerungszeit	t _{d(off)}	T _j =25°C T _j =125°C	R _{goff} = 36 Ohm R _{gon} = 36 Ohm	±15	600	25		495		ns
Fall time Fallzeit	t _f	T _j =25°C T _j =125°C	R _{goff} = 36 Ohm R _{gon} = 36 Ohm	±15	600	25		207		ns
Turn-on energy loss per pulse Einschaltverlustenergie pro Puls	E _{on}	T _j =25°C T _j =125°C	R _{goff} = 36 Ohm R _{gon} = 36 Ohm	±15	600	25		3,15		mWs
Turn-off energy loss per pulse Abschaltverlustenergie pro Puls	E _{off}	T _j =25°C T _j =125°C	R _{goff} = 36 Ohm R _{gon} = 36 Ohm	±15	600	25		2,8		mWs
Input capacitance Eingangskapazität	C _{ies}	T _j =25°C T _j =125°C	f=1MHz	0	25			1,8		nF
Output capacitance Ausgangskapazität	C _{oss}	T _j =25°C T _j =125°C	f=1MHz	0	25			0,3		nF
Reverse transfer capacitance Rückwirkungskapazität	C _{rss}	T _j =25°C T _j =125°C	f=1MHz	0	25			0,2		nF
Gate charge Gate Ladung	Q _{Gate}	T _j =25°C T _j =125°C	V _{CE} =600V I _C pulse=25A	±15				160		nC
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R _{thJH}		Thermal grease thickness≤50um					1,25		K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R _{thJC}		Wärmeleitpaste Dicke≤50um λ = 0,61 W/mK					0,83		K/W
Coupled thermal resistance inverter diode-transistor	R _{thJH}		Thermal grease thickness≤50um					0,4		K/W
Gekoppelte Wärmewiderstand Wechselrichter Diode-Transistor			Wärmeleitpaste Dicke≤50um λ = 0,61 W/mK							

Characteristic values

Description	Symbol	Conditions					Values			Unit
		T(°C)	Other conditions (Rgon-Rgoff)	V _{GE} (V) V _{GS} (V)	V _R (V) V _{CE} (V) V _{DS} (V)	I _C (A) I _F (A) I _d (A)	Min	Typ	Max	
Diode Inverter										
Diode Wechselrichter										
Diode forward voltage Durchlaßspannung	V _F	T _J =25°C				25	1,4	1,7	2,2	V
Peak reverse recovery current Rückstromspitze	I _{RM}	T _J =25°C	Rgon= 36 Ohm		600	25		1,77		A
Reverse recovery time Reverse recovery time	t _{rr}	T _J =25°C	Rgon= 36 Ohm		600	25		33		ns
Reverse recovered charge Sperrverzögerungsladung	Q _{rr}	T _J =25°C	Rgon= 36 Ohm		600	25		5,7		uC
Reverse recovered energy Sperrverzögerungsenergie	E _{rec}	T _J =25°C	Rgon= 36 Ohm		600	25		2,22		mWs
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R _{thJH}		Thermal grease thickness≤50um					1,71		K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R _{thJC}		Wärmeleitpaste Dicke≤50um λ = 0,61 W/mK					1,13		K/W
Transistor BRC										
Transistor BRC										
Gate emitter threshold voltage Gate-Schwellenspannung	V _{GE(th)}	T _J =25°C	VCE=VGE			0,001	5	5,8	6,5	V
Collector-emitter saturation voltage Kollektor-Emitter Sättigungsspannung	V _{CE(sat)}	T _J =25°C		15	25	1,35	1,61	2,15		V
Collector-emitter cut-off Kollektor-Emitter Reststrom	I _{CES}	T _J =25°C		0	1224	0		0,05		mA
Gate-emitter leakage current Gate-Emitter Reststrom	I _{GES}	T _J =25°C		±25	0	0		300		nA
Integrated Gate resistor Integriertes Gate Widerstand	R _{gint}									Ohm
Turn-on delay time Einschaltverzögerungszeit	t _{d(on)}	T _J =25°C	Rgoff= 36 Ohm							ns
Rise time Anstiegszeit	t _r	T _J =25°C	Rgon= 36 Ohm	±15	600	25		72,2		ns
Turn-off delay time Abschaltverzögerungszeit	t _{d(off)}	T _J =25°C	Rgoff= 36 Ohm							ns
Fall time Fallzeit	t _f	T _J =25°C	Rgon= 36 Ohm	±15	600	25		481		ns
Turn-on energy loss per pulse Einschaltverlustenergie pro Puls	E _{on}	T _J =25°C	Rgoff= 36 Ohm							mWs
Turn-off energy loss per pulse Abschaltverlustenergie pro Puls	E _{off}	T _J =25°C	Rgon= 36 Ohm	±15	600	25		3,18		mWs
SC withstand time Kurzschlußverhalten	t _{sc}	T _J =150°C		15	1200			10		us
Input capacitance Eingangskapazität	C _{iss}	T _J =25°C	f=1MHz	0	25			1,8		nF
Output capacitance Ausgangskapazität	C _{oss}	T _J =25°C	f=1MHz	0	25			0,3		nF
Reverse transfer capacitance Rückwirkungskapazität	C _{ies}	T _J =25°C	f=1MHz	0	25			0,2		nF
Gate charge Gate Ladung	Q _{gate}	T _J =25°C	VCE=600V ICpulse=25A	±15				160		nC
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R _{thJH}		Thermal grease thickness≤50um					1,01		K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R _{thJC}		Wärmeleitpaste Dicke≤50um λ = 0,61 W/mK					0,67		K/W

Characteristic values

Description	Symbol	Conditions					Values			Unit
		T(°C)	Other conditions (Rgon-Rgoff)	VGE(V) VGS(V)	V _R (V) V _{CE} (V) V _{DS} (V)	I _C (A) I _F (A) I _d (A)	Min	Typ	Max	
Diode BRC										
Diode BRC										
Diode forward voltage Durchlaßspannung	V _F	T _j =25°C T _j =125°C				25 25	1,4	1,52	2,2	V
Reverse current Sperrstrom	I _r	T _j =25°C T _j =125°C			1224		0		50	µA
Reverse recovery time Sperrverzögerungszeit	t _{rr}	T _j =25°C T _j =125°C	Rgon= 36 Ohm diF/dt = 875 A/us	0	600	25		625,6		ns
Reverse recovered charge Sperrverzögerungsladung	Q _{rr}	T _j =25°C T _j =125°C	Rgon= 36 Ohm diF/dt = 875 A/us	0	600	25		5,41		µC
Reverse recovery energy Sperrverzögerungsenergie	E _{rec}	T _j =25°C T _j =125°C	Rgon= 36 Ohm diF/dt = 875 A/us	0	600	25		2,13		mWs
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R _{thJH}		Thermal grease thickness≤50µm					1,54		K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R _{thJC}		Wärmeleitpaste Dicke≤50µm λ = 0,61 W/mK					1,02		K/W
PTC-Thermistor										
PTC-Widerstand										
Nominal resistance Nominaler Widerstand	R ₂₅ R ₁₀₀	T _j =25°C T _j =100°C	tolerance = 3% tolerance = 2%				0,97 1,637	1 1,67	1,03 1,703	kOhm kOhm
Typical temperature coefficient Typischer Temperaturkoeffizient	α	T _j =25°C T _j =125°C						0,76		%/K
Recommended measuring current Empfohlener Messstrom	I _m	T _j =25°C T _j =125°C					1		3	mA
Measured values Gemessene Werte	V _{PTC}	T _j =25°C	I _m = 1mA I _m = 3mA				0,93 2,84		1,03 3,4	V

Output inverter

Figure 1. Typical output characteristics
Output inverter IGBT
 $I_c = f(V_{CE})$

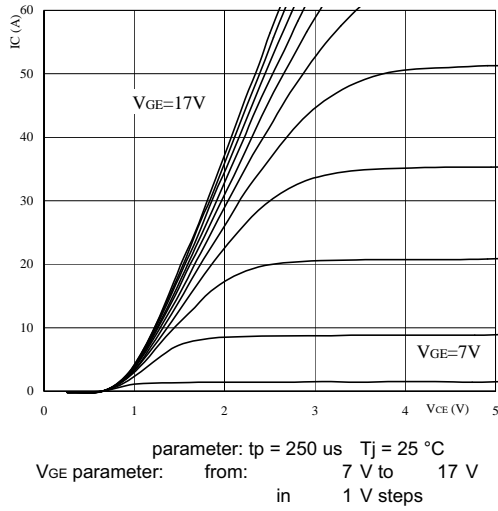


Figure 2. Typical output characteristics
Output inverter IGBT
 $I_c = f(V_{CE})$

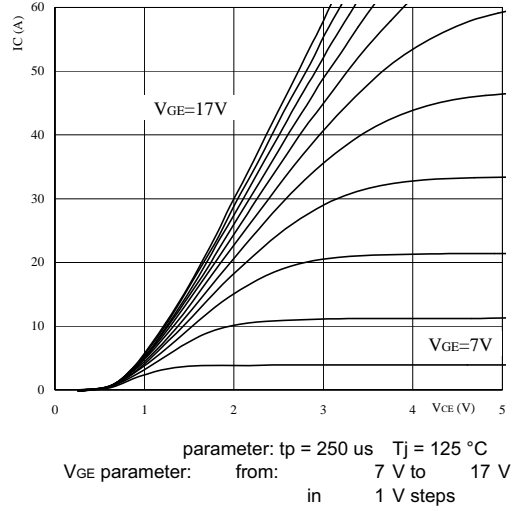


Figure 3. Typical transfer characteristics
Output inverter IGBT
 $I_c = f(V_{GE})$

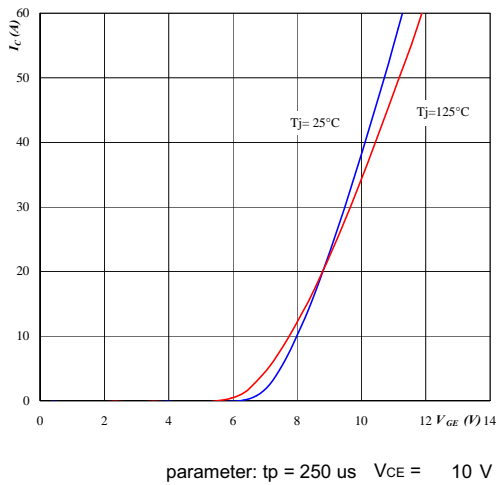
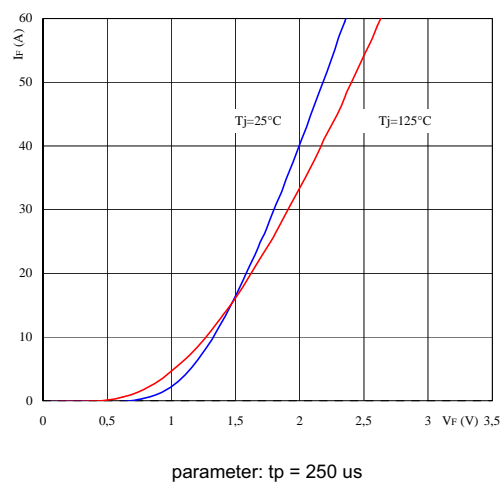
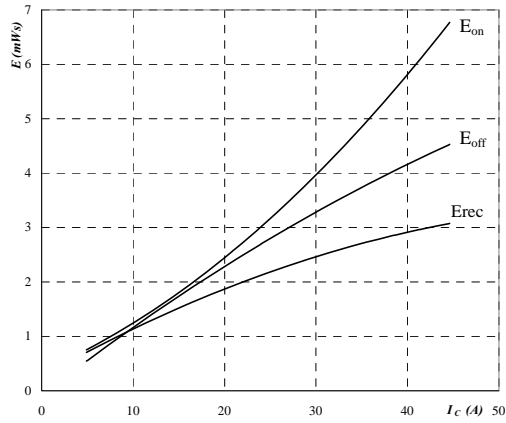


Figure 4. Typical diode forward current as a function of forward voltage
Output inverter FRED $I_F = f(V_F)$



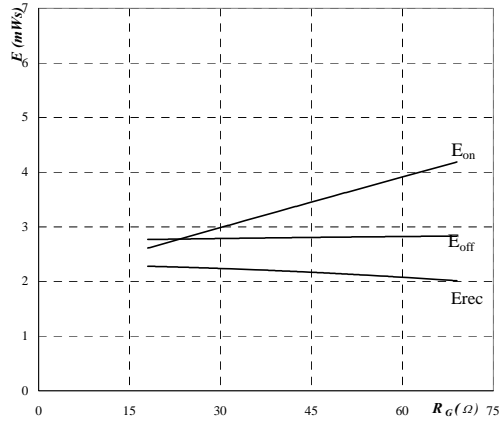
Output inverter

Figure 5. Typical switching energy losses as a function of collector current
Output inverter IGBT
 $E = f(I_c)$



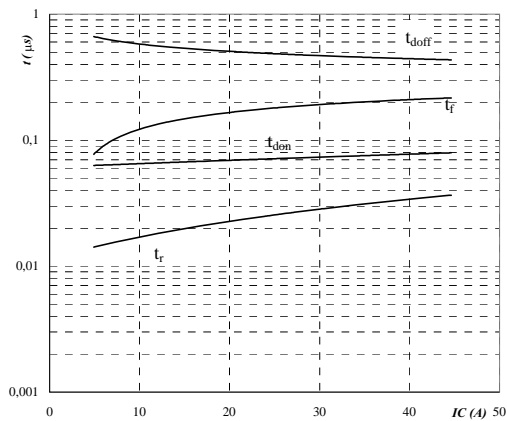
inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $R_{gon} = 36\ \Omega$
 $R_{goff} = 36\ \Omega$

Figure 6. Typical switching energy losses as a function of gate resistor
Output inverter IGBT
 $E = f(R_G)$



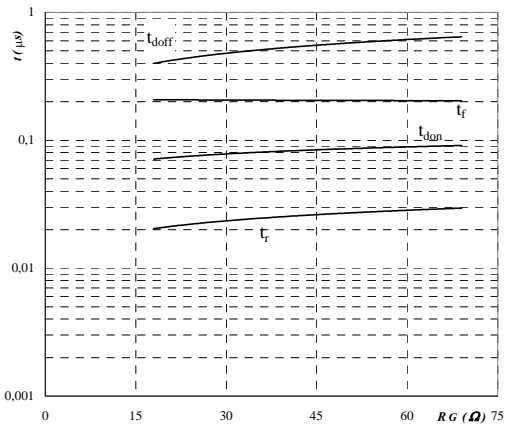
inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $I_c = 25\text{ A}$

Figure 7. Typical switching times as a function of collector current
Output inverter IGBT
 $t = f(I_c)$



inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $R_{gon} = 36\ \Omega$
 $R_{goff} = 36\ \Omega$

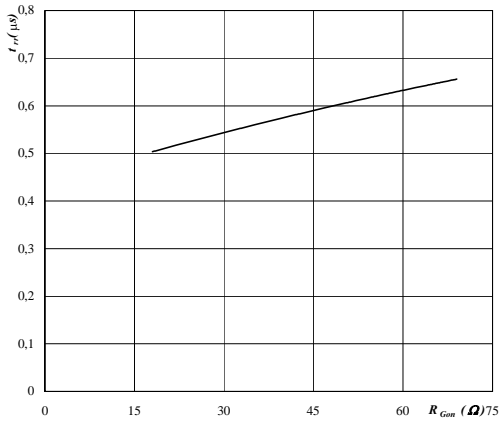
Figure 8. Typical switching times as a function of gate resistor
Output inverter IGBT
 $t = f(R_G)$



inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $I_c = 25\text{ A}$

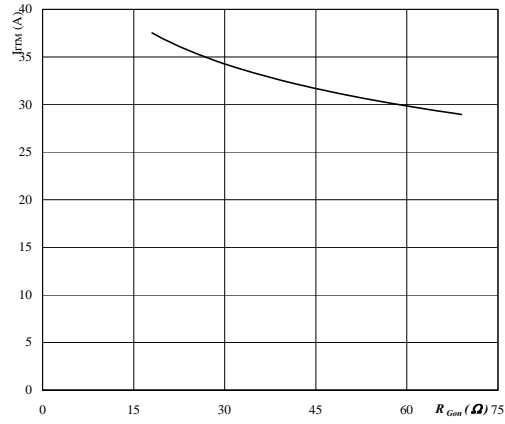
Output inverter

Figure 9. Typical reverse recovery time as a function of IGBT turn on gate resistor
Output inverter FRED diode
 $t_{rr} = f(R_{gon})$



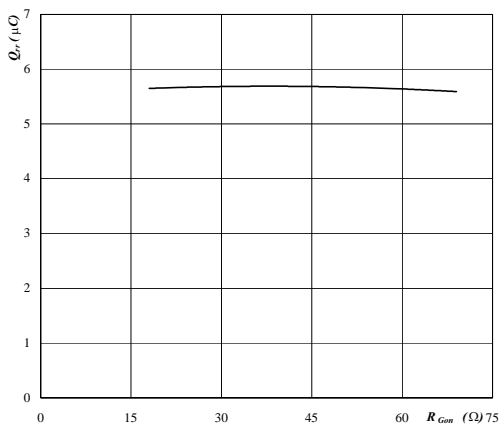
$T_j = 125\text{ }^\circ\text{C}$
 $V_R = 600\text{ V}$
 $I_F = 25\text{ A}$
 $V_{GE} = \pm 15\text{ V}$

Figure 10. Typical reverse recovery current as a function of IGBT turn on gate resistor
Output inverter FRED diode
 $I_{RRM} = f(R_{gon})$



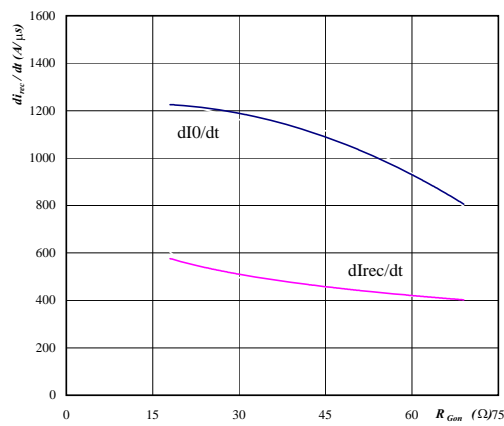
$T_j = 125\text{ }^\circ\text{C}$
 $V_R = 600\text{ V}$
 $I_F = 25\text{ A}$
 $V_{GE} = \pm 15\text{ V}$

Figure 11. Typical reverse recovery charge as a function of IGBT turn on gate resistor
Output inverter FRED diode
 $Q_{rr} = f(R_{gon})$



$T_j = 125\text{ }^\circ\text{C}$
 $V_R = 600\text{ V}$
 $I_F = 25\text{ A}$
 $V_{GE} = \pm 15\text{ V}$

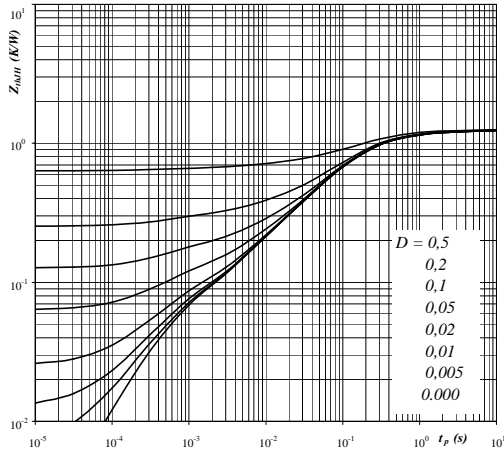
Figure 12. Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor
Output inverter FRED diode
 $dI_0/dt, dI_{rec}/dt = f(R_{gon})$



$T_j = 125\text{ }^\circ\text{C}$
 $V_R = 600\text{ V}$
 $I_F = 25\text{ A}$
 $V_{GE} = \pm 15\text{ V}$

Output inverter

Figure 13. IGBT transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$

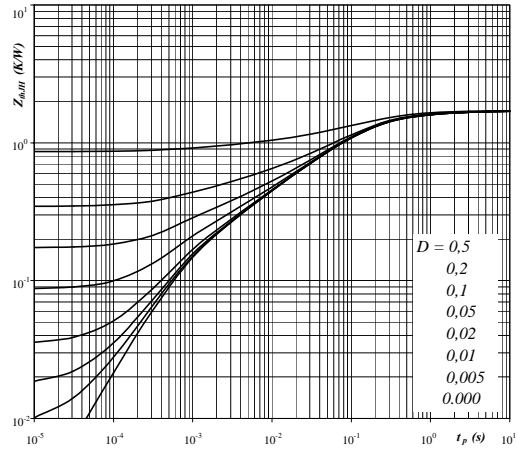


Parameter: $D = t_p / T$ RthJH: 1,25 K/W

IGBT thermal model values

R (C/W)	Tau (s)
0,05	2,1E+01
0,13	1,5E+00
0,61	2,0E-01
0,33	5,3E-02
0,10	7,0E-03
0,05	4,9E-04
0,05	1,2E-04
0,00	0,0E+00

Figure 14. FRED transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$

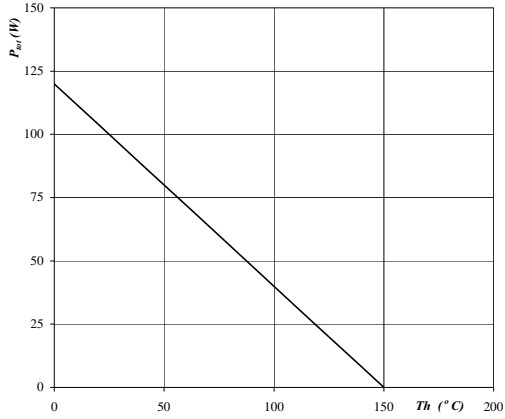


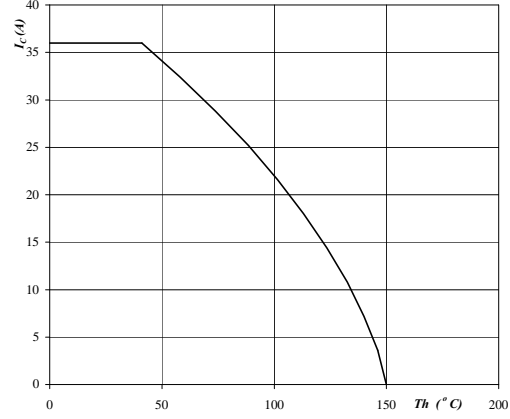
Parameter: $D = t_p / T$ RthJH= 1,71 K/W

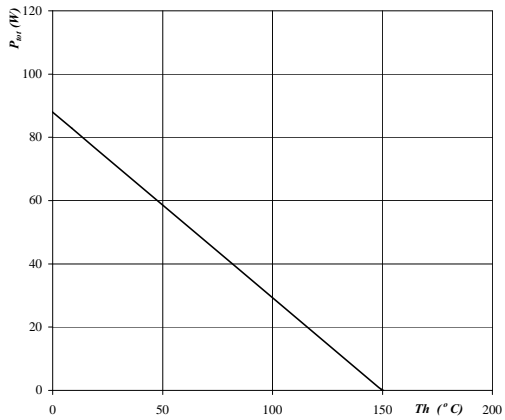
FRED thermal model values

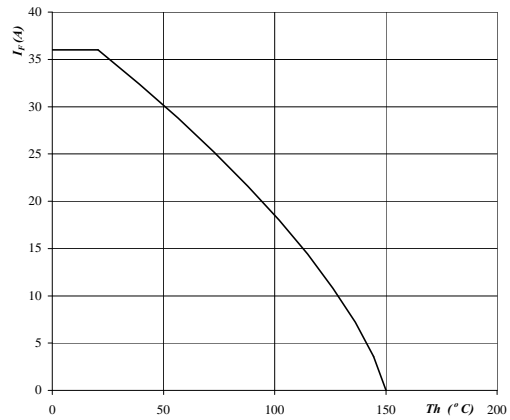
R (C/W)	Tau (s)
0,06	1,9E+01
0,16	1,2E+00
0,65	1,8E-01
0,48	4,7E-02
0,23	7,4E-03
0,15	8,3E-04
0,09	4,7E-04
0,06	1,4E-04

Output inverter
Figure 15. Power dissipation as a function of heatsink temperature

 Output inverter IGBT
 $P_{tot} = f(T_h)$

 parameter: $T_j = 150^{\circ}C$
Figure 16. Collector current as a function of heatsink temperature

 Output inverter IGBT
 $I_c = f(T_h)$

 parameter: $T_j = 150^{\circ}C$
 $V_{GE} = 15 V$
Figure 17. Power dissipation as a function of heatsink temperature

 Output inverter FRED
 $P_{tot} = f(T_h)$

 parameter: $T_j = 150^{\circ}C$
Figure 18. Forward current as a function of heatsink temperature

 Output inverter FRED
 $I_F = f(T_h)$

 parameter: $T_j = 150^{\circ}C$

Brake

Figure 19. Typical output characteristics
Brake IGBT
 $I_C = f(V_{CE})$

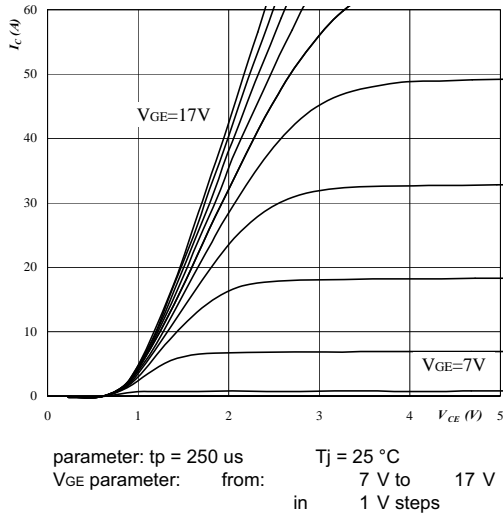


Figure 20. Typical output characteristics
Brake IGBT
 $I_C = f(V_{CE})$

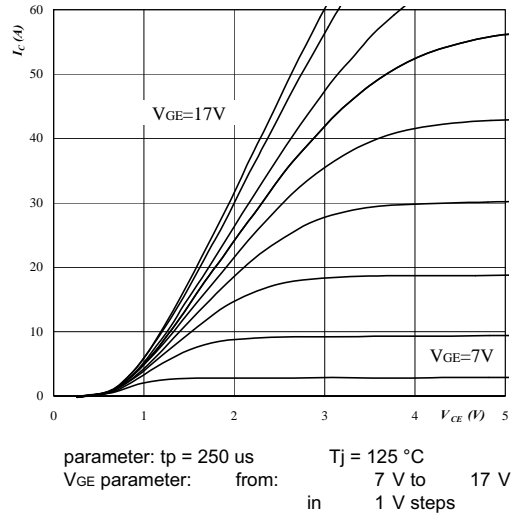


Figure 21. Typical transfer characteristics
Brake IGBT
 $I_C = f(V_{GE})$

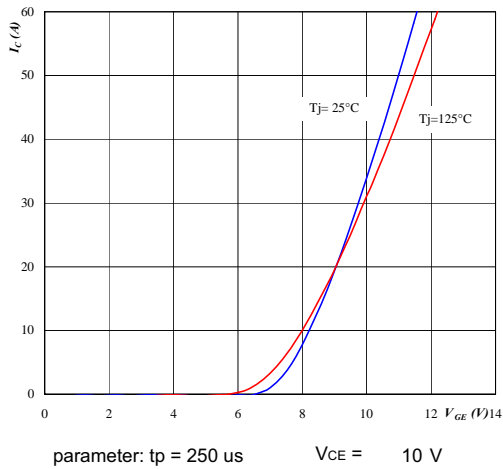
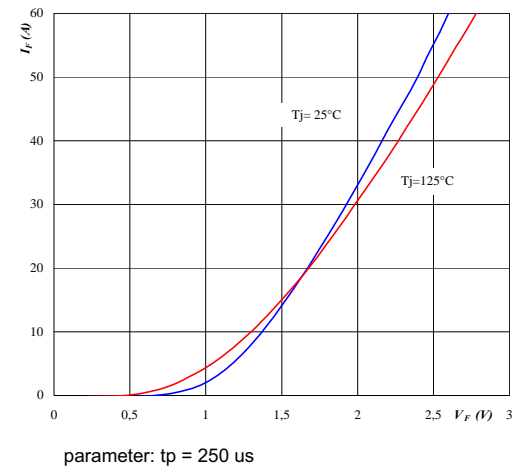
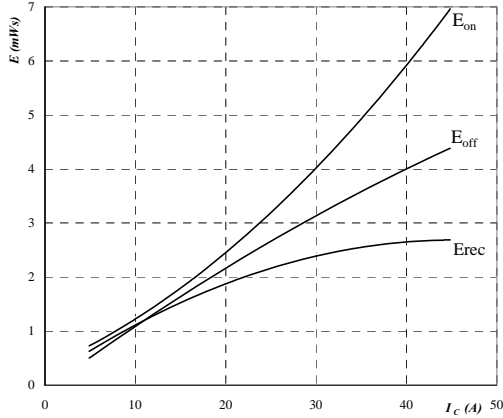


Figure 22. Typical diode forward current as a function of forward voltage
Brake FRED $I_F = f(V_F)$



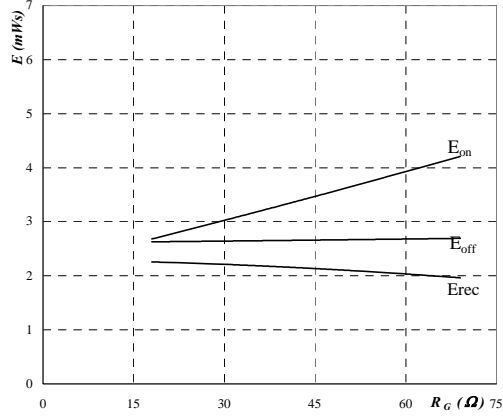
Brake

Figure 23. Typical switching energy losses as a function of collector current
Brake IGBT
 $E = f(I_c)$



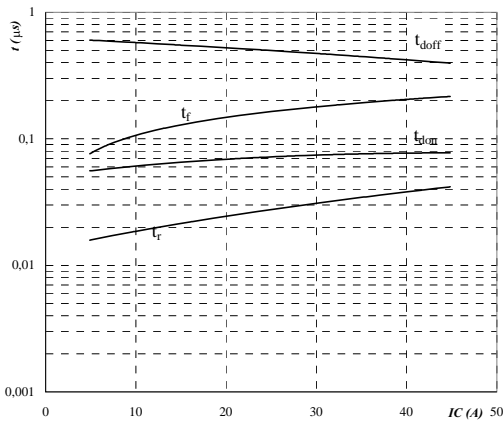
inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $R_{gon} = 36\text{ }\Omega$
 $R_{goff} = 36\text{ }\Omega$

Figure 24. Typical switching energy losses as a function of gate resistor
Brake IGBT
 $E = f(R_g)$



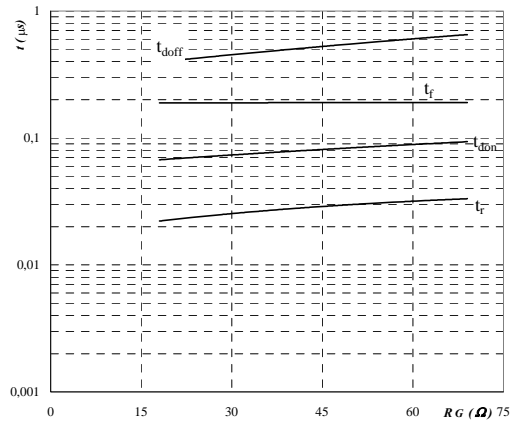
inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $I_c = 25\text{ A}$

Figure 25. Typical switching times as a function of collector current
Brake IGBT
 $t = f(I_c)$



inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $R_{gon} = 36\text{ }\Omega$
 $R_{goff} = 36\text{ }\Omega$

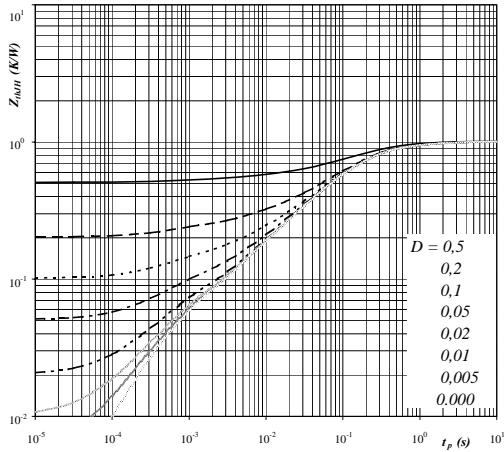
Figure 26. Typical switching times as a function of gate resistor
Brake IGBT
 $t = f(R_g)$



inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 600\text{ V}$
 $V_{GE} = \pm 15\text{ V}$
 $I_c = 25\text{ A}$

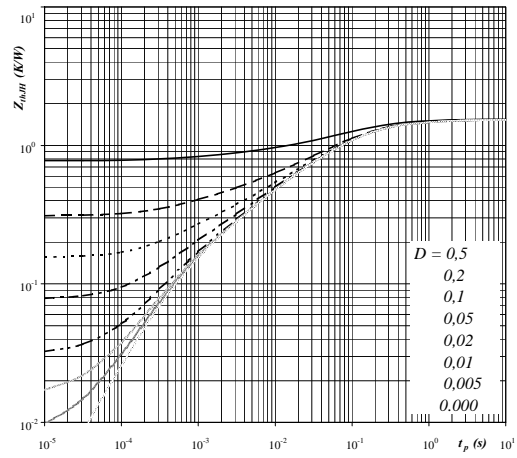
Brake

Figure 27. IGBT transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$



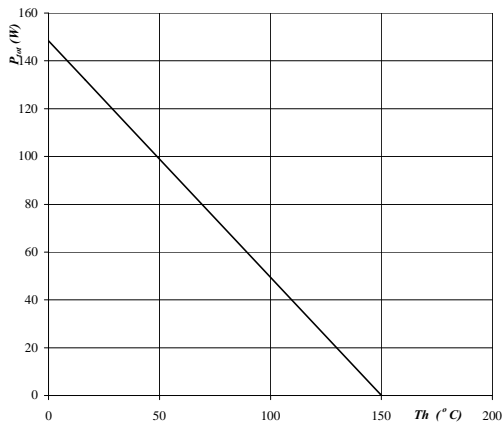
Parameter: $D = t_p / T$ $R_{thJH} = 1,01 \text{ K/W}$

Figure 28. FRED transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$



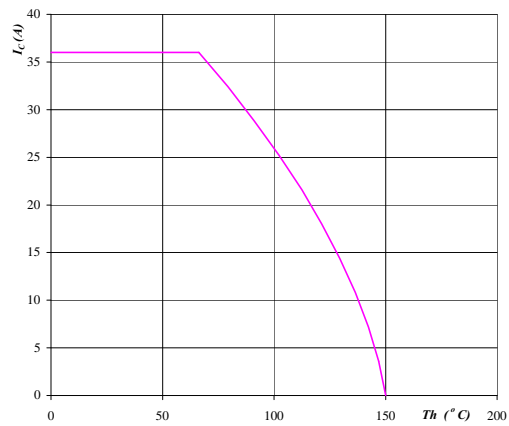
Parameter: $D = t_p / T$ $R_{thJH} = 1,54 \text{ K/W}$

Figure 29. Power dissipation as a function of heatsink temperature
Brake IGBT
 $P_{tot} = f(T_h)$



parameter: $T_j = 150^\circ\text{C}$

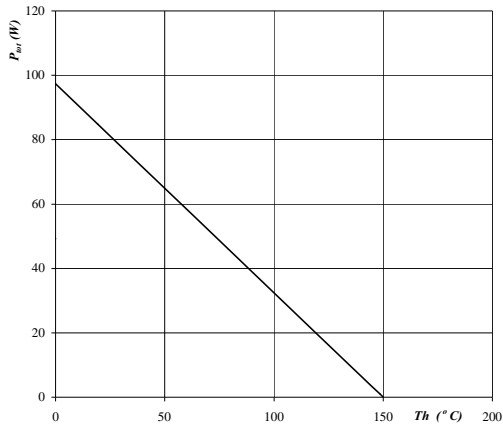
Figure 30. Collector current as a function of heatsink temperature
Brake IGBT
 $I_c = f(T_h)$



parameter: $T_j = 150^\circ\text{C}$
 $V_{GE} = 15 \text{ V}$

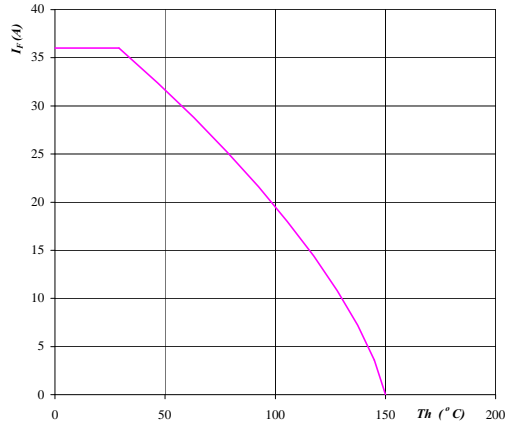
Brake

Figure 31. Power dissipation as a function of heatsink temperature
Brake FRED
 $P_{tot} = f(T_h)$



parameter: $T_j = 150^\circ\text{C}$

Figure 32. Forward current as a function of heatsink temperature
Brake FRED
 $I_F = f(T_h)$



parameter: $T_j = 150^\circ\text{C}$

Input rectifier bridge

Figure 33. Typical diode forward current as a function of forward voltage
Rectifier diode $I_F = f(V_F)$

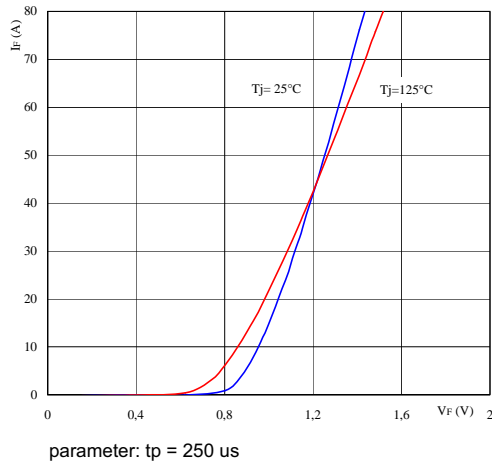


Figure 34. Diode transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$

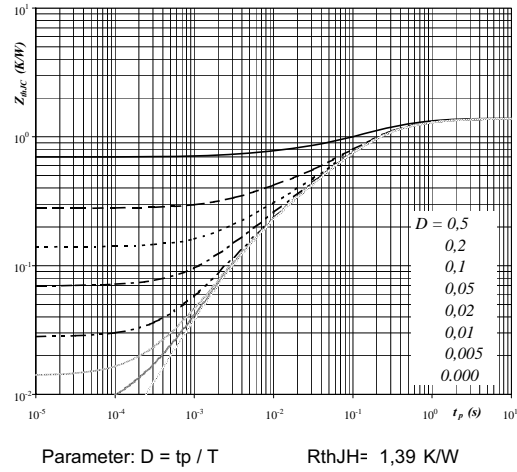


Figure 35. Power dissipation as a function of heatsink temperature
Rectifier diode $P_{tot} = f(T_h)$

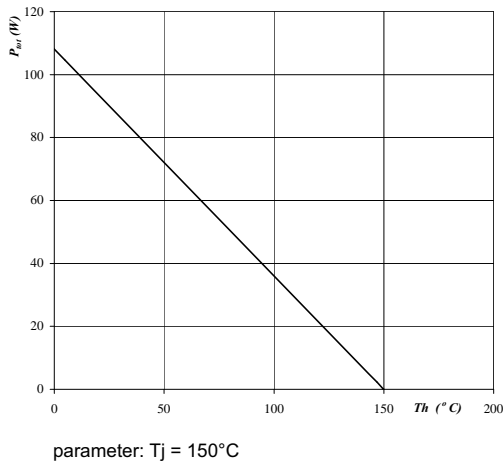
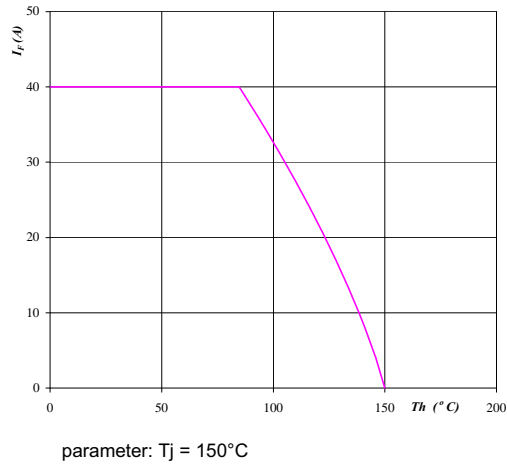


Figure 36. Forward current as a function of heatsink temperature
Rectifier diode $I_F = f(T_h)$



Thermistor

**Figure 37. Typical PTC characteristic
as a function of temperature**

$$R_T = f(T)$$

